Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/534,491	MASUDA ET AL.	
Examiner	Art Unit	
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	SEARCHED			
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Class	Subclass	Date	Examiner	
206	219, 220	9/25/2006	LKB	
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	459.1			
	459.5			
ABOVE	UPDATE	3/22/07		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

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